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The datasheet number will be changing.

Device Family	Change From:	Change To:
TPS92662-Q1- Available on ti.com	SLUSD15A	SLUSD15B
TPS92662-Q1- Available upon request	SLUSCU8	SLUSCU8B

These changes may be reviewed at the datasheet links provided. <u>http://www.ti.com/product/TPS92662-Q1</u>

The datasheet for TPS92662-Q1 (Lit# SLUSCU8B) is available upon request. Contact the CQE to request the updated version of the datasheet.

Reason for Change:

To accurately reflect device characteristics.

Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.

Changes to product identification resulting from this notification.								
None.								
None.								
Product Affected:								
TPS92662QPHPRQ1	TPS92662QPHPTQ1							
		identification resulting from this notification:TPS92662QPHPRQ1TPS92662QPHPTQ1						

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